

<b>Notice of References Cited</b>	Application/Control No. 10/612,786	Applicant(s)/Patent Under Reexamination ABE ET AL.
	Examiner Matthew J. Ludwig	Art Unit 2178

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*	A	US-2002/0054090 A1	05-2002	Silva et al.	345/747
*	B	US-6,785,673	08-2004	Fernandez et al.	707/3
*	C	US-6,848,079	01-2005	Ito, Naoko	715/523
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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